## Notice of References Cited Application/Control No. 10/743,082 Examiner Jason T. Whipkey Applicant(s)/Patent Under Reexamination FURUKAWA, SHINJI Page 1 of 1

## U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-2002/0154898 A1	10-2002	Hisatomi et al.	386/95
*	В	US-6,791,620 B1	09-2004	Elswick et al.	348/441
*	С	US-6,920,610 B1	07-2005	Lawton et al.	715/209
*	D	US-2005/0128510 A1	06-2005	Campbell, Michael Clark	358/001.15
*	Е	US-2004/0028290 A1	02-2004	Gamble, William	382/284
*	F	US-2003/0090690 A1	05-2003	Katayama et al.	348/222.1
	G	US-			
	Ι	US-			
	_	US-			
	٦	US-			
	K	US-			
	┙	US-			
	М	US-			

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	FR 2849511 A1	07-2004	France	MOLHO, JACQUES ALBERT	G06F 3/00
	0	JP 09223155 A	08-1997	Japan	SATO et al.	G06F 17/30
	Р	JP 05334370 A	12-1993	Japan	YAMAKOSHI et al.	G06F 15/40
	Q					
	R					
	S					
	Т					

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	٧	
	W	
	×	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.